

# IEEE AUTOTESTCON 2020

August 24-27, 2020 ★ National Harbor, Maryland

Gaylord National Convention Center



Increasing System Availability Through Advanced Test and Support Technology

## CALL FOR PAPERS

### IMPORTANT DATES

**March 30, 2020**

Abstracts Deadline

### ORGANIZING COMMITTEE

#### GENERAL CHAIR

**Bob Rassa**

Raytheon Company  
RCRassa@raytheon.com

#### TECHNICAL PROGRAM CHAIR

**Steve Fairbanks**

Astronics Corp



AUTOTESTCON is the world's premier conference that brings together the military/aerospace automatic test industry and government/military acquirers and users to share new technologies, discuss innovative applications, and exhibit products and services. It is sponsored annually by the Institute of Electrical and Electronic Engineers (IEEE).

AUTOTESTCON will be held at the Gaylord National Harbor Resort, National Harbor, MD, USA, on August 24-27, 2020. The technical program for AUTOTESTCON 2020 will be determined by the interests of those participants submitting for publication, presenting a technical paper or organizing a technical session. Papers and sessions should cover appropriate topics dealing with increasing DoD systems availability and automatic test technology in particular.

### KEY TOPICS

Performance Based    Logistics    Health Monitoring & Diagnostics    Embedded Instrumentation    Support Economics    Test & Support Management    Cyber Security



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[2020.autotestcon.com](http://2020.autotestcon.com)

- » Spiral Development and Evolutionary Acquisition
- » Flexible Sustainment
- » Interoperability
- » Design-For-Test/Built-In-Test
- » Fault Tolerant Systems
- » Legacy ATE Challenges
- » Future Logistics Support Concepts
- » Contractor Logistics Support
- » Maintenance Repair & Overhaul
- » Multinational Integrated Support
- » Commercialization of Military Maintenance
- » Electronic Warfare Test and Applications
- » CMMI Application to ATE/TPS Development
- » DMSMS Approaches
- » Organizational/Intermediate/Depot Level Maintenance For The Future
- » Next Generation Test Systems
- » Test Program Set Development
- » Prognostics
- » Test Requirements Definition and Verification
- » Factory and Development Test
- » Software Testing and Research
- » Development in Instrumentation and Measurement

### SUBMISSION

Abstracts are to be submitted to the Abstract Management website no later than March 30, 2020, at <http://edas.info>. Questions and Session proposals should be addressed to the Technical Program or General Chairs.